

# TC74VCX02FT, TC74VCX02FK

## Low-Voltage Quad 2-Input NOR Gate with 3.6-V Tolerant Inputs and Outputs

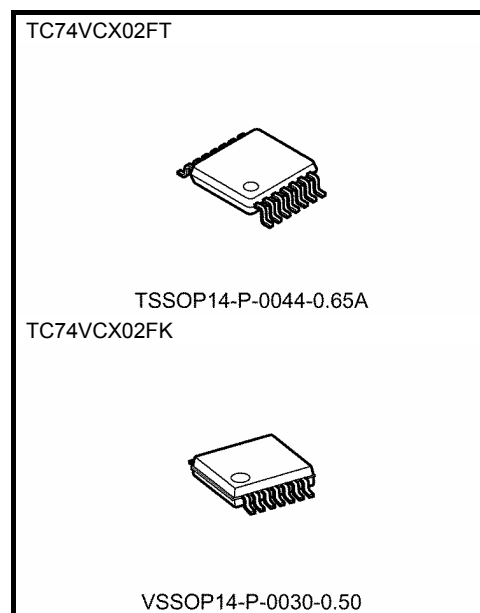
The TC74VCX02FT/FK is a high-performance CMOS 2-input NOR gate which is guaranteed to operate from 1.2-V to 3.6-V. Designed for use in 1.5V, 1.8V, 2.5V or 3.3V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

It is also designed with overvoltage tolerant inputs and outputs up to 3.6 V.

All inputs are equipped with protection circuits against static discharge.

### Features

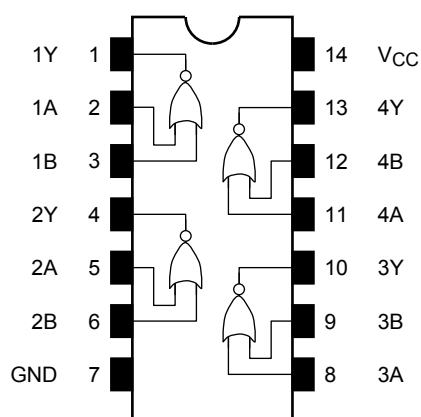
- Low-voltage operation:  $V_{CC} = 1.2 \sim 3.6 \text{ V}$
- High-speed operation:  $t_{pd} = 2.8 \text{ ns (max)} (V_{CC} = 3.0 \sim 3.6 \text{ V})$   
 :  $t_{pd} = 3.7 \text{ ns (max)} (V_{CC} = 2.3 \sim 2.7 \text{ V})$   
 :  $t_{pd} = 7.4 \text{ ns (max)} (V_{CC} = 1.65 \sim 1.95 \text{ V})$   
 :  $t_{pd} = 14.8 \text{ ns (max)} (V_{CC} = 1.4 \sim 1.6 \text{ V})$   
 :  $t_{pd} = 37.0 \text{ ns (max)} (V_{CC} = 1.2 \text{ V})$
- Output current:  $I_{OH}/I_{OL} = \pm 24 \text{ mA (min)} (V_{CC} = 3.0 \text{ V})$   
 :  $I_{OH}/I_{OL} = \pm 18 \text{ mA (min)} (V_{CC} = 2.3 \text{ V})$   
 :  $I_{OH}/I_{OL} = \pm 6 \text{ mA (min)} (V_{CC} = 1.65 \text{ V})$   
 :  $I_{OH}/I_{OL} = \pm 2 \text{ mA (min)} (V_{CC} = 1.4 \text{ V})$
- Latch-up performance:  $-300 \text{ mA}$
- ESD performance: Machine model  $\geq \pm 200 \text{ V}$   
 Human body model  $\geq \pm 2000 \text{ V}$
- Package: TSSOP and VSSOP (US)
- Power-down protection provided on all inputs and outputs



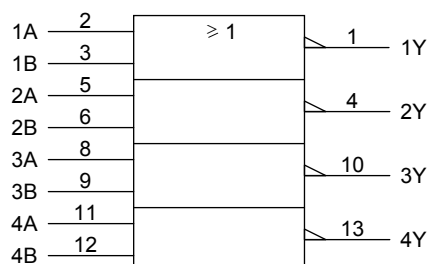
### Weight

TSSOP14-P-0044-0.65A	: 0.06 g (typ.)
VSSOP14-P-0030-0.50	: 0.02 g (typ.)

## Pin Assignment (top view)



## IEC Logic Symbol



## Truth Table

Inputs		Outputs
A	B	Y
L	L	H
L	H	L
H	L	L
H	H	L

## Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	$V_{CC}$	-0.5~4.6	V
DC input voltage	$V_{IN}$	-0.5~4.6	V
DC output voltage	$V_{OUT}$	-0.5~4.6 (Note 2)	V
		-0.5~ $V_{CC} + 0.5$ (Note 3)	
Input diode current	$I_{IK}$	-50	mA
Output diode current	$I_{OK}$	±50 (Note 4)	mA
DC output current	$I_{OUT}$	±50	mA
Power dissipation	$P_D$	180	mW
DC $V_{CC}$ /ground current	$I_{CC}/I_{GND}$	±100	mA
Storage temperature	$T_{stg}$	-65~150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2:  $V_{CC} = 0$  V

Note 3: High or low state.  $I_{OUT}$  absolute maximum rating must be observed.

Note 4:  $V_{OUT} < GND$ ,  $V_{OUT} > V_{CC}$

## Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	$V_{CC}$	1.2~3.6	V
Input voltage	$V_{IN}$	-0.3~3.6	V
Output voltage	$V_{OUT}$	0~3.6 (Note 2)	V
		0~ $V_{CC}$ (Note 3)	
Output current	$I_{OH}/I_{OL}$	$\pm 24$ (Note 4)	mA
		$\pm 18$ (Note 5)	
		$\pm 6$ (Note 6)	
		$\pm 2$ (Note 7)	
Operating temperature	$T_{opr}$	-40~85	°C
Input rise and fall time	$dt/dv$	0~10 (Note 8)	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device.  
Unused inputs must be tied to either  $V_{CC}$  or GND.

Note 2:  $V_{CC} = 0$  V

Note 3: High or low state

Note 4:  $V_{CC} = 3.0\sim 3.6$  V

Note 5:  $V_{CC} = 2.3\sim 2.7$  V

Note 6:  $V_{CC} = 1.65\sim 1.95$  V

Note 7:  $V_{CC} = 1.4\sim 1.6$  V

Note 8:  $V_{IN} = 0.8\sim 2.0$  V,  $V_{CC} = 3.0$  V

## Electrical Characteristics

### DC Characteristics ( $T_a = -40$ to $85^\circ\text{C}$ , $2.7\text{ V} < V_{CC} \leq 3.6\text{ V}$ )

Characteristics		Symbol	Test Condition		Min	Max	Unit	
					V <sub>CC</sub> (V)			
Input voltage	H-level	V <sub>IH</sub>	—		2.7~3.6	2.0	—	V
	L-level	V <sub>IL</sub>	—		2.7~3.6	—	0.8	
Output voltage	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IL</sub>	I <sub>OH</sub> = −100 μA	2.7~3.6	V <sub>CC</sub> − 0.2	—	V
				I <sub>OH</sub> = −12 mA	2.7	2.2	—	
				I <sub>OH</sub> = −18 mA	3.0	2.4	—	
				I <sub>OH</sub> = −24 mA	3.0	2.2	—	
	L-level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	2.7~3.6	—	0.2	
				I <sub>OL</sub> = 12 mA	2.7	—	0.4	
				I <sub>OL</sub> = 18 mA	3.0	—	0.4	
				I <sub>OL</sub> = 24 mA	3.0	—	0.55	
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		2.7~3.6	—	±5.0	μA
Power-off leakage current		I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V		0	—	10.0	μA
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		2.7~3.6	—	20.0	μA
Increase in I <sub>CC</sub> per input			V <sub>CC</sub> ≤ V <sub>IN</sub> ≤ 3.6 V		2.7~3.6	—	±20.0	
		ΔI <sub>CC</sub>	V <sub>IH</sub> = V <sub>CC</sub> − 0.6 V		2.7~3.6	—	750	

**DC Characteristics ( $T_a = -40$  to  $85^\circ\text{C}$ ,  $2.3\text{ V} \leq V_{CC} \leq 2.7\text{ V}$ )**

Characteristics		Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Max	Unit
Input voltage	H-level	V <sub>IH</sub>	—		2.3~2.7	1.6	—	V
	L-level	V <sub>IL</sub>	—		2.3~2.7	—	0.7	
Output voltage	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IL</sub>	I <sub>OH</sub> = −100 μA	2.3~2.7	V <sub>CC</sub> − 0.2	—	V
				I <sub>OH</sub> = −6 mA	2.3	2.0	—	
				I <sub>OH</sub> = −12 mA	2.3	1.8	—	
				I <sub>OH</sub> = −18 mA	2.3	1.7	—	
	L-level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	2.3~2.7	—	0.2	
				I <sub>OL</sub> = 12 mA	2.3	—	0.4	
				I <sub>OL</sub> = 18 mA	2.3	—	0.6	
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		2.3~2.7	—	±5.0	μA
Power-off leakage current		I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V		0	—	10.0	μA
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		2.3~2.7	—	20.0	μA
			V <sub>CC</sub> ≧ V <sub>IN</sub> ≧ 3.6 V		2.3~2.7	—	±20.0	

**DC Characteristics ( $T_a = -40$  to  $85^\circ\text{C}$ ,  $1.65\text{ V} \leq V_{CC} < 2.3\text{ V}$ )**

Characteristics		Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Max	Unit
Input voltage	H-level	V <sub>IH</sub>	—		1.65~2.3	0.65 × V <sub>CC</sub>	—	V
	L-level	V <sub>IL</sub>	—		1.65~2.3	—	0.2 × V <sub>CC</sub>	
Output voltage	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IL</sub>	I <sub>OH</sub> = −100 μA	1.65~2.3	V <sub>CC</sub> − 0.2	—	V
				I <sub>OH</sub> = −6 mA	1.65	1.25	—	
	L-level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	1.65~2.3	—	0.2	
				I <sub>OL</sub> = 6 mA	1.65	—	0.3	
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		1.65~2.3	—	±5.0	μA
Power-off leakage current		I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V		0	—	10.0	μA
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		1.65~2.3	—	20.0	μA
			V <sub>CC</sub> ≤ V <sub>IN</sub> ≤ 3.6 V		1.65~2.3	—	±20.0	

**DC Characteristics ( $T_a = -40$  to  $85^\circ\text{C}$ ,  $1.4\text{ V} \leq V_{CC} < 1.65\text{ V}$ )**

Characteristics		Symbol	Test Condition			Min	Max	Unit	
			V <sub>CC</sub> (V)						
Input voltage	H-level	V <sub>IH</sub>	—		1.4~1.65	0.65 × V <sub>CC</sub>	—	V	
	L-level	V <sub>IL</sub>	—		1.4~1.65	—	0.05 × V <sub>CC</sub>		
Output voltage	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IL</sub>	I <sub>OH</sub> = −100 μA	1.4~1.65	V <sub>CC</sub> − 0.2	—	V	
				I <sub>OH</sub> = −2 mA	1.4	1.05	—		
	L-level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	1.4~1.65	—	0.05		
				I <sub>OL</sub> = 2 mA	1.4	—	0.35		
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V			1.4~1.65	—	±5.0	μA
Power-off leakage current		I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V			0	—	10.0	μA
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND			1.4~1.65	—	20.0	μA
			V <sub>CC</sub> ≤ V <sub>IN</sub> ≤ 3.6 V			1.4~1.65	—	±20.0	

**DC Characteristics ( $T_a = -40$  to  $85^\circ\text{C}$ ,  $1.2\text{ V} \leq V_{CC} < 1.4\text{ V}$ )**

Characteristics		Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Max	Unit
Input voltage	H-level	V <sub>IH</sub>	—		1.2~1.4	$0.8 \times V_{CC}$	—	V
	L-level	V <sub>IL</sub>	—		1.2~1.4	—	$0.05 \times V_{CC}$	
Output voltage	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IL</sub>	I <sub>OH</sub> = -100 $\mu\text{A}$	1.2	$V_{CC} - 0.1$	—	V
	L-level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 $\mu\text{A}$	1.2	—	0.05	
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		1.2	—	$\pm 5.0$	$\mu\text{A}$
Power-off leakage current		I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V		0	—	10.0	$\mu\text{A}$
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		1.2	—	20.0	$\mu\text{A}$
			$V_{CC} \leq V_{IN} \leq 3.6\text{ V}$		1.2	—	$\pm 20.0$	

**AC Characteristics (Ta = -40 to 85°C, input:  $t_r = t_f = 2.0$  ns) (Note 1)**

Characteristics	Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Max	Unit
Propagation delay time	$t_{pLH}$ $t_{pHL}$	Figure 1, Figure 2	$C_L = 15$ pF, $R_L = 2$ k $\Omega$	1.2	3.0	37.0	ns
				$1.5 \pm 0.1$	2.0	14.8	
			$C_L = 30$ pF, $R_L = 500$ $\Omega$	$1.8 \pm 0.15$	1.5	7.4	
				$2.5 \pm 0.2$	0.8	3.7	
				$3.3 \pm 0.3$	0.6	2.8	
Output to output skew	$t_{osLH}$ $t_{osHL}$	(Note 2)	$C_L = 15$ pF, $R_L = 2$ k $\Omega$	1.2	—	1.5	ns
				$1.5 \pm 0.1$	—	1.5	
			$C_L = 30$ pF, $R_L = 500$ $\Omega$	$1.8 \pm 0.15$	—	0.5	
				$2.5 \pm 0.2$	—	0.5	
				$3.3 \pm 0.3$	—	0.5	

Note 1: For  $C_L = 50$  pF, add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design.

( $t_{osLH} = |t_{pLHm} - t_{pLHn}|$ ,  $t_{osHL} = |t_{pHLm} - t_{pHLn}|$ )

**Dynamic Switching Characteristics (Ta = 25°C, input:  $t_r = t_f = 2.0$  ns,  $C_L = 30$  pF)**

Characteristics	Symbol	Test Condition		V <sub>CC</sub> (V)	Typ.	Unit
Quiet output maximum dynamic V <sub>OL</sub>	V <sub>OLP</sub>	$V_{IH} = 1.8$ V, $V_{IL} = 0$ V	(Note)	1.8	0.25	V
		$V_{IH} = 2.5$ V, $V_{IL} = 0$ V	(Note)	2.5	0.6	
		$V_{IH} = 3.3$ V, $V_{IL} = 0$ V	(Note)	3.3	0.8	
Quiet output minimum dynamic V <sub>OL</sub>	V <sub>OLV</sub>	$V_{IH} = 1.8$ V, $V_{IL} = 0$ V	(Note)	1.8	-0.25	V
		$V_{IH} = 2.5$ V, $V_{IL} = 0$ V	(Note)	2.5	-0.6	
		$V_{IH} = 3.3$ V, $V_{IL} = 0$ V	(Note)	3.3	-0.8	
Quiet output minimum dynamic V <sub>OH</sub>	V <sub>OHV</sub>	$V_{IH} = 1.8$ V, $V_{IL} = 0$ V	(Note)	1.8	1.5	V
		$V_{IH} = 2.5$ V, $V_{IL} = 0$ V	(Note)	2.5	1.9	
		$V_{IH} = 3.3$ V, $V_{IL} = 0$ V	(Note)	3.3	2.2	

Note: Parameter guaranteed by design.

**Capacitive Characteristics (Ta = 25°C)**

Characteristics	Symbol	Test Condition		V <sub>CC</sub> (V)	Typ.	Unit
Input capacitance	C <sub>IN</sub>	—		1.8, 2.5, 3.3	6	pF
Power dissipation capacitance	C <sub>PD</sub>	$f_{IN} = 10$ MHz	(Note)	1.8, 2.5, 3.3	20	pF

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC(opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/4 \text{ (per gate)}$$

AC Test Circuit

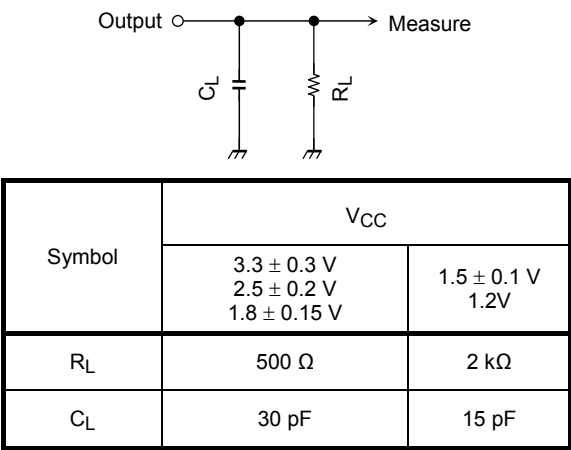
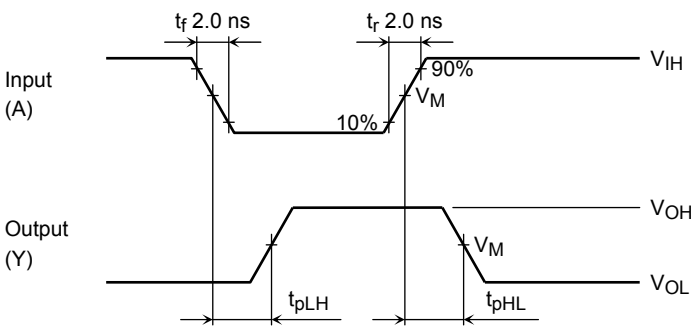


Figure 1

AC Waveform



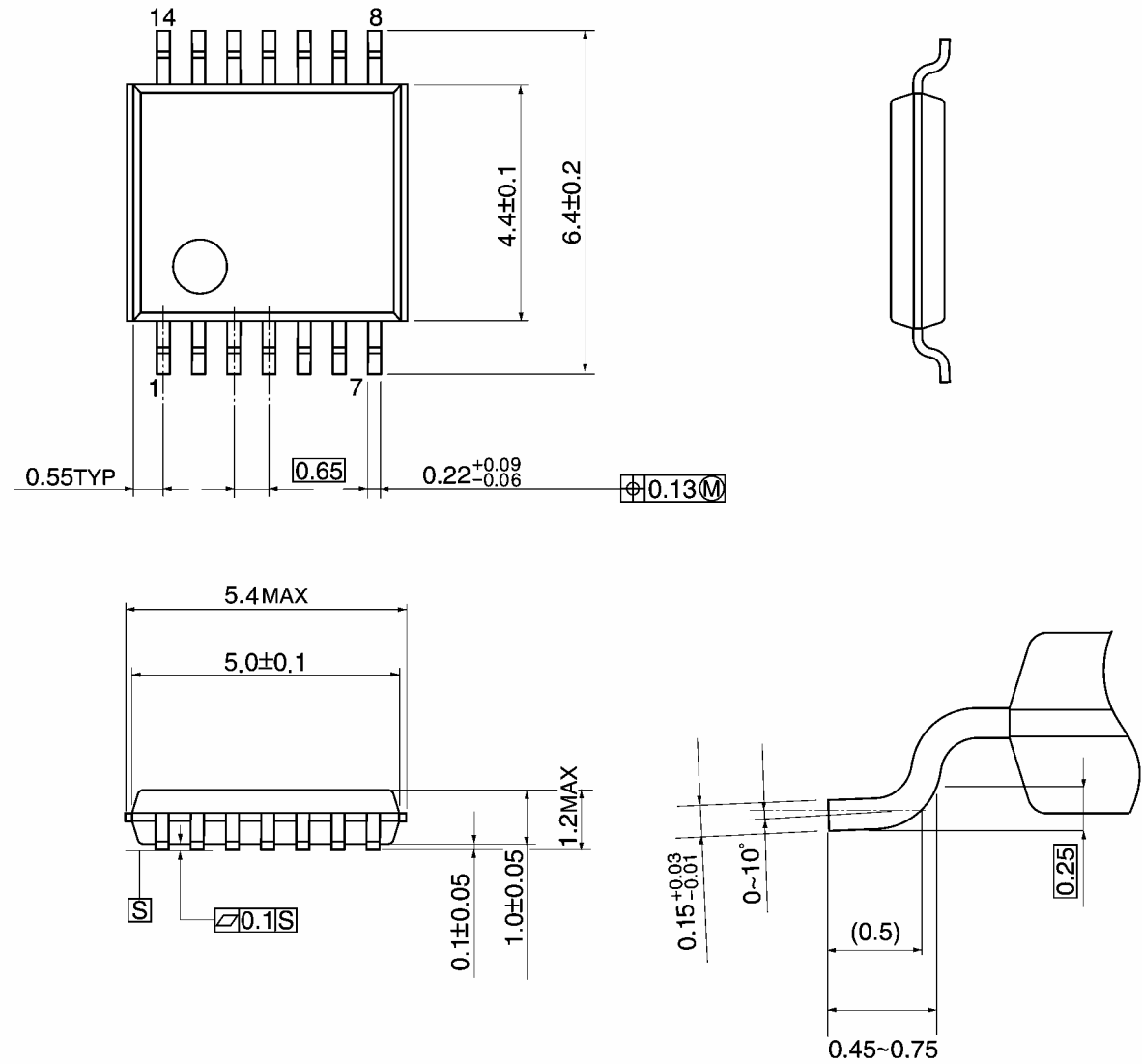
Symbol	$V_{CC}$				
	$3.3 \pm 0.3 \text{ V}$	$2.5 \pm 0.2 \text{ V}$	$1.8 \pm 0.15 \text{ V}$	$1.5 \pm 0.1 \text{ V}$	$1.2 \text{ V}$
$V_{IH}$	$2.7 \text{ V}$	$V_{CC}$	$V_{CC}$	$V_{CC}$	$V_{CC}$
$V_M$	$1.5 \text{ V}$	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$

Figure 2  $t_{pLH}$ ,  $t_{pHL}$

Package Dimensions

TSSOP14-P-0044-0.65A

Unit: mm



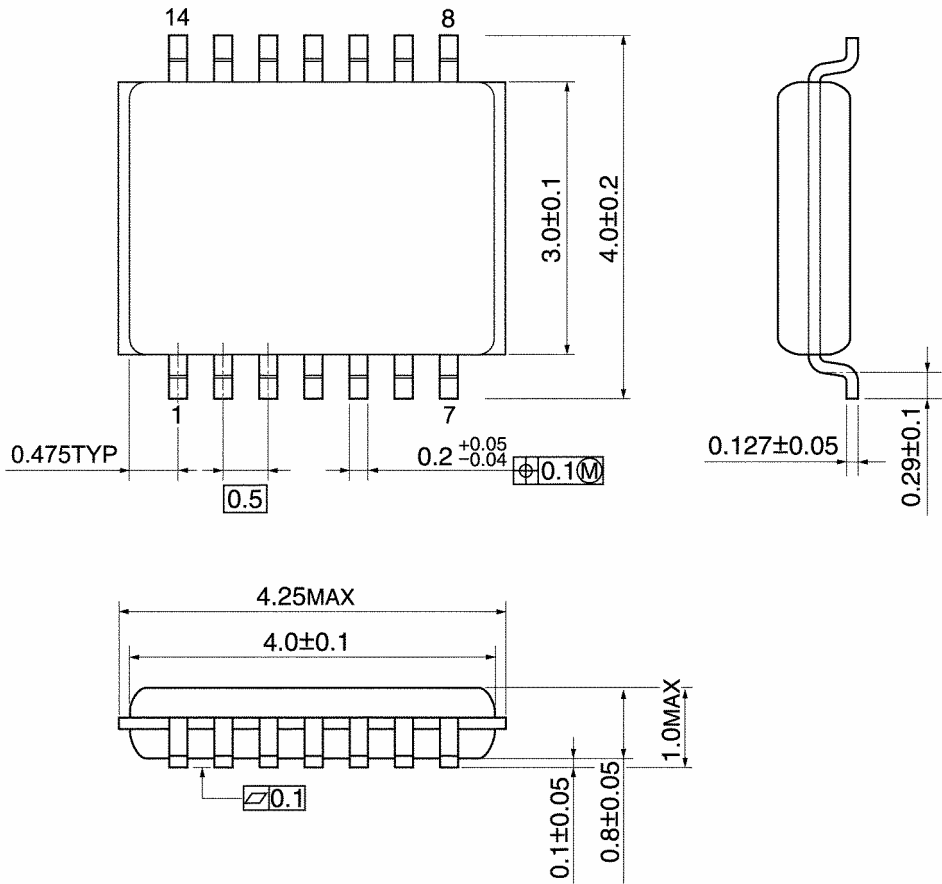
Weight: 0.06 g (typ.)



Package Dimensions

VSSOP14-P-0030-0.50

Unit: mm



Weight: 0.02 g (typ.)

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20070701-EN GENERAL

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